

**Notice of References Cited**Application/Control No.  
09/667,706Applicant(s)/Patent Under  
Reexamination  
INOUE ET AL.Examiner  
Douglas W OwensArt Unit  
2811

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,107,154	08-2000	Lin, Yung-Chang	438/396
*	B	US-6,190,957	02-2001	Mochizuki et al.	438/240
*	C	US-6,200,834	03-2001	Bronner et al.	438/142
*	D	US-6,214,676	04-2001	Jun et al.	438/279
*	E	US-6,300,206	10-2001	Fukada et al.	438/303
*	F	US-6,303,432	10-2001	Horita et al.	438/253
	G	US-5,981,324 ✓	11-1999	Seo et al.	438/210
	H	US-6,150,248 ✓	11-2000	Sekiguchi et al.	438/592
	I	US-6,436,753 ✓	08-2002	Ikeda et al.	438/238
	J	US-6,579,784 ✓	06-2003	Huang, Jenn Ming	438/595
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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